

## PRELIMINARY

PM75CLB060

FLAT-BASE TYPE  
INSULATED PACKAGE

Notice : This is not a final specification. Some parametric limits are subject to change.

PM75CLB060

Pre.	<i>T. Marumo</i>	Rev.	
Apr.	<i>A. Takemoto Aug-02</i>		

## Feature

a) Adopting new 5th generation IGBT(CSTBT) chip, which performance is improved by  $1\mu\text{m}$  fine rule process.

For example, typical  $V_{ce(\text{sat})}=1.5\text{V}$  @ $T_j=125^\circ\text{C}$

b) Adopt the over-temperature conservation by  $T_j$  detection of CSTBT chip, and error output is possible from upper arm and a lower arm of IPM at all each protection.

c) New small package

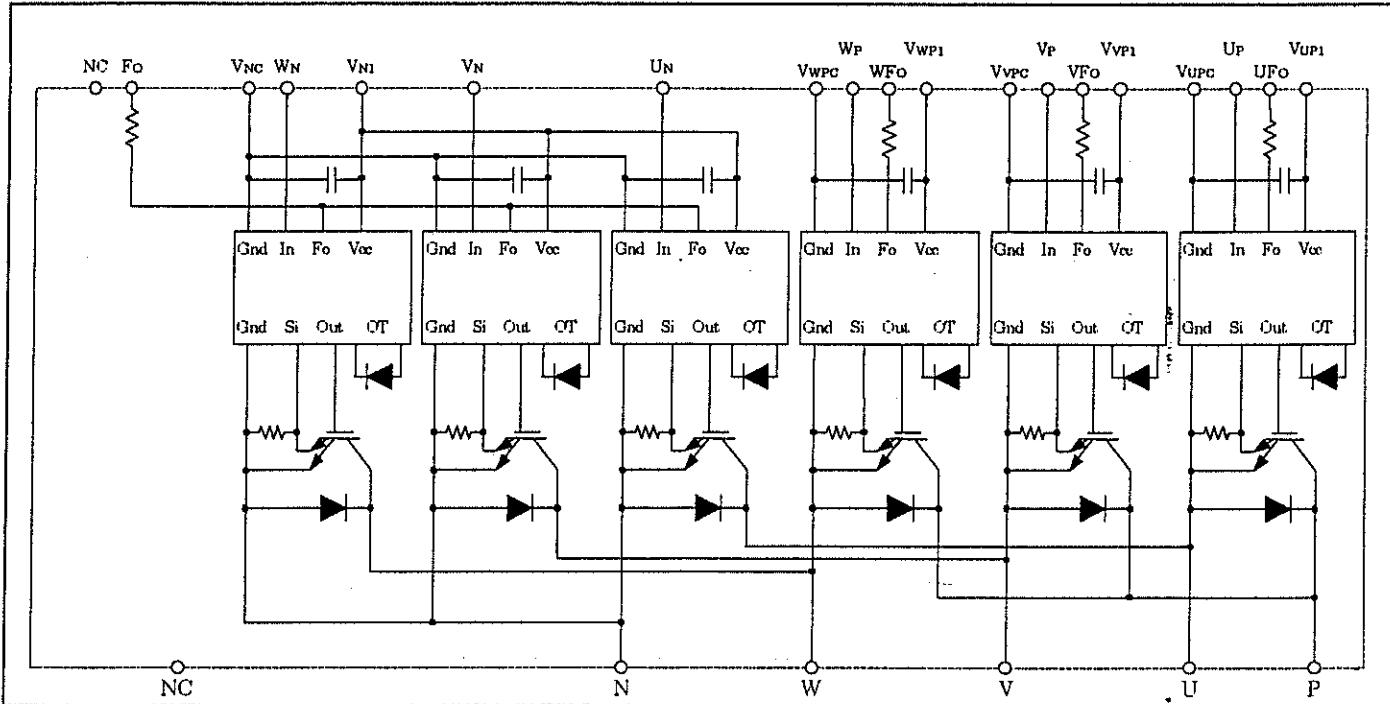
Reduce the package size by 32%, thickness by 22% from S-DASH series.

## OUTLINE DRAWING Dimensions in mm

See Page 7

- 3φ 75A, 600V Current-sense IGBT type inverter
- Monolithic gate drive & protection logic
- Detection, protection & status indication circuits for, short-circuit, over-temperature & under-voltage (P-Fo available from upper arm devices)
- Acoustic noise-less 5.5kW/7.5kW class inverter application

APPLICATION : General purpose inverter, servo drives and other motor controls



Maximum Ratings ( $T_j = 25^\circ\text{C}$ , unless otherwise noted)

## Inverter Part

Item	Symbol	Condition	Ratings	Unit
Collector-Emitter Voltage	$V_{CES}$	$V_D = 15\text{V}, V_{CIN} = 15\text{V}$	600	V
Collector Current	$\pm I_C$	$T_C = 25^\circ\text{C}$	75	A
Collector Current (Peak)	$\pm I_{CP}$	$T_C = 25^\circ\text{C}$	150	A
Collector Dissipation	$P_C$	$T_C = 25^\circ\text{C}$	416	W
Junction Temperature	$T_j$		-20 ~ +150	°C

## Control Part

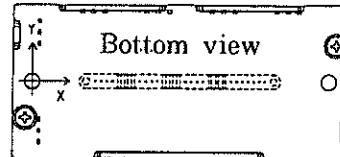
Item	Symbol	Condition	Rating	Unit
Supply Voltage	$V_D$	Applied between : $V_{UP1}\text{-}V_{UPC}$ $V_{VP1}\text{-}V_{VPc}$ , $V_{WP1}\text{-}V_{WPc}$ , $V_{N1}\text{-}V_{NC}$	20	V
Input Voltage	$V_{CIN}$	Applied between : $U_P\text{-}V_{UPC}$ , $V_P\text{-}V_{VPc}$ $W_P\text{-}V_{WPc}$ , $U_N\text{-}V_N$ , $W_N\text{-}V_{NC}$	20	V
Fault Output Supply Voltage	$V_{FO}$	Applied between : $U_{FO}\text{-}V_{UPC}$ , $V_{FO}\text{-}V_{VPc}$ $W_{FO}\text{-}V_{WPc}$ , $F_O\text{-}V_{NC}$	20	
Fault Output Current	$I_{FO}$	Sink current at $U_{FO}$ , $V_{FO}$ , $W_{FO}$ , $F_O$ terminals	20	mA

## Total System

Item	Symbol	Condition	Rating	Unit
Supply Voltage Protected by SC	$V_{CC(\text{PROT})}$	$V_D = 13.5\sim 16.5\text{V}$ Inverter Part, $T_j = +125^\circ\text{C}$ Start	400	V
Supply Voltage (Surge)	$V_{CC(\text{surge})}$	Applied between : P-N, Surge value	500	V
Module Case Operating Temperature	$T_C$	(Note-1)	-20 ~ +100	°C
Storage Temperature	$T_{\text{stg}}$		-40 ~ +125	°C
Isolation Voltage	$V_{iso}$	60Hz, Sinusoidal Charged part to Base, AC 1 min.	2500	Vrms

(Note-1)  $T_C$ (under the chip) measurement point is below. (unit : mm)

axis \ arm	UP		VP		WP		UN		VN		WN	
	IGBT	FWDi										
X	28.7	28.7	65.2	65.2	85.3	85.3	38.0	38.0	55.4	55.4	75.5	75.5
Y	-6.6	0.85	-6.6	2.5	-6.6	2.5	4.6	-4.5	4.6	-4.5	4.6	-4.5



## Thermal Resistances

Item	Symbol	Condition	Min.	Typ.	Max.	Unit
Junction to case	$R_{th(j-c)Q}$	Inverter IGBT part (per 1/6) (Note-1)	-	-	0.30*	°C/W
Thermal Resistances	$R_{th(j-c)F}$	Inverter FWDi part (per 1/6) (Note-1)	-	-	0.52*	
Contact Thermal Resistance	$R_{th(c-f)}$	Case to fin, (per 1 module) Thermal grease applied	-	-	**	

\* If you use this value,  $R_{th(f-a)}$  should be measured just under the chips.

\*\*: This value is not specified yet.

Electrical Characteristics (T<sub>j</sub> = 25°C unless otherwise noted)

## Inverter Part

Item	Symbol	Condition		Min.	Typ.	Max.	Unit
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	V <sub>D</sub> = 15V, V <sub>CIN</sub> = 0V	T <sub>j</sub> = 25°C	—	1.5	2.0	V
		I <sub>C</sub> = 75A, Pulsed	Fig.1 T <sub>j</sub> = 125°C	—	1.5	2.0	
FWD <sub>i</sub> Forward Voltage	V <sub>EC</sub>	I <sub>C</sub> = 75A, V <sub>CIN</sub> = 15V V <sub>D</sub> = 15V	Fig.2	—	2.2	3.3	V
Switching Time	ton	V <sub>D</sub> = 15V, V <sub>CIN</sub> = 0V ↔ 15V V <sub>CC</sub> = 300V, I <sub>C</sub> = 75A T <sub>j</sub> = 125°C, Inductive Load	Fig.3	0.8	1.2	2.4	μs
	trr			—	0.15	0.3	
	t <sub>c(on)</sub>			—	0.4	1.0	
	t <sub>off</sub>			—	2.0	2.8	
	t <sub>c(off)</sub>			—	0.6	1.2	
Collector-Emitter Cutoff Current	I <sub>CES</sub>	V <sub>CE</sub> = V <sub>CES</sub>	T <sub>j</sub> = 25°C	—	—	1	mA
		V <sub>D</sub> = 15V	Fig.4 T <sub>j</sub> = 125°C	—	—	10	

## Control Part

Item	Symbol	Condition		Min.	Typ.	Max.	Unit	
Circuit Current	I <sub>D</sub>	V <sub>D</sub> = 15V	V <sub>N1</sub> -V <sub>NC</sub>	—	20	30	mA	
		V <sub>CIN</sub> = 15V	V <sub>XPI</sub> -V <sub>XPC</sub>	—	6	10		
Input ON Threshold Voltage	V <sub>th(ON)</sub>	Applied between : U <sub>P</sub> -V <sub>UPC</sub> , V <sub>P</sub> -V <sub>VPC</sub>		1.2	1.5	1.8	V	
Input OFF Threshold Voltage	V <sub>th(OFF)</sub>	W <sub>P</sub> -V <sub>WPC</sub> , U <sub>N</sub> -V <sub>N</sub> , W <sub>N</sub> -V <sub>NC</sub>		1.7	2.0	2.3		
Short Circuit Trip Level	SC	-20 ≤ T <sub>j</sub> ≤ 125°C Fig.5,6 V <sub>D</sub> = 15V		Fig.5,6	150	241	—	A
Short Circuit Current Delay Time	t <sub>off(SC)</sub>	V <sub>D</sub> = 15V		Fig.5,6	—	10	—	μs
Over Temperature Protection	OT	Detect T <sub>j</sub> of IGBT chip	Trip level	135	145	155	°C	
	OTr		Reset level	—	125	—		
Supply Circuit Under-Voltage Protection	UV	-20 ≤ T <sub>j</sub> ≤ 125°C	Trip level	11.5	12.0	12.5	V	
	UVr		Reset level	—	12.5	—		
Fault Output Current	I <sub>FO(H)</sub>	V <sub>D</sub> = 15V, V <sub>CIN</sub> = 15V	(Note-2)	—	—	0.01	mA	
	I <sub>FO(L)</sub>		(Note-2)	—	10	15		
Minimum Fault Output Pulse Width	t <sub>FO</sub>	V <sub>D</sub> = 15V	(Note-2)	1.0	1.8	—	ms	

(Note-2) Fault output is given only when the internal SC, OT &amp; UV protections schemes of either upper or lower arm device operate to protect it.

## Mechanical Ratings and characteristics

Item	Symbol	Condition	Min.	Typ.	Max.	Unit
Mounting torque	—	Mounting part screw : M 5	2.5	3.0	3.5	N · m
Weight	—	—	—	300	—	g

## Recommended Conditions For Use

Item	Symbol	Condition	Recommended value	Unit	
Supply Voltage	V <sub>CC</sub>	Applied across P-N terminals	≤ 400	V	
Control Supply Voltage	V <sub>D</sub>	Applied between : V <sub>UP1</sub> -V <sub>UPC</sub> V <sub>VP1</sub> -V <sub>VPC</sub> , V <sub>WP1</sub> -V <sub>WPC</sub> , V <sub>N1</sub> -V <sub>NC</sub> (Note-3)	15.0±1.5	V	
Input ON Voltage	V <sub>CIN(ON)</sub>	Applied between : U <sub>P</sub> -V <sub>UPC</sub> , V <sub>P</sub> -V <sub>VPC</sub> W <sub>P</sub> -V <sub>WPC</sub> , U <sub>N</sub> -V <sub>N</sub> , W <sub>N</sub> -V <sub>NC</sub>	≤ 0.8	V	
Input OFF Voltage	V <sub>CIN(OFF)</sub>		≥ 4.0		
PWM Input Frequency	f <sub>PWM</sub>	Using Application Circuit of Fig.8	≤ 20	kHz	
Arm Shoot-through Blocking Time	t <sub>dead</sub>	For IPM's each input signals	Fig.7	≥ 2.0	μ

(Note-3) With ripple satisfying the following conditions  
 $dv/dt$  swing ≤ ±5V/μs, Variation ≤ 2V peak to peak

## Precautions for testing

1. Before applying any control supply voltage ( V<sub>D</sub> ), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state. After this, the specified ON and OFF level setting for each input signal should be done.
2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above V<sub>CES</sub> rating of the device.  
 ( These test should not be done by using a curve tracer or its equivalent. )

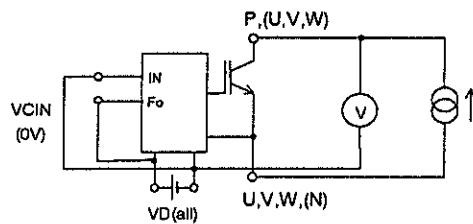


Fig.1 VCE(sat) Tset

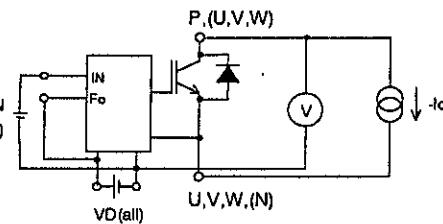


Fig.2 VEC Tset

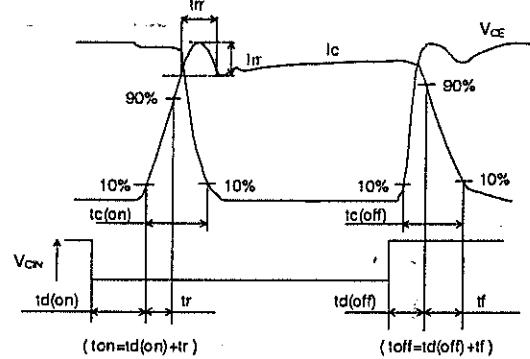
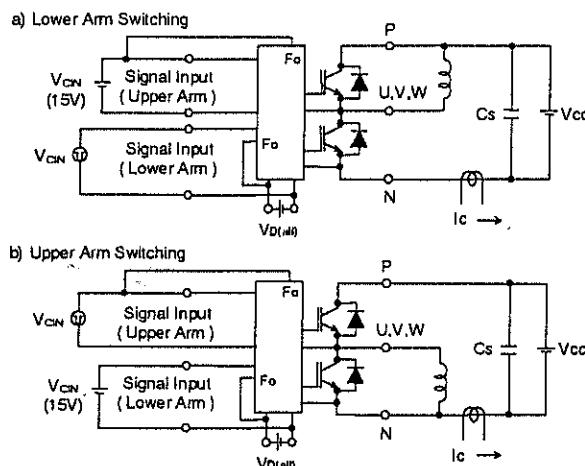


Fig.3 Switching time test circuit and waveform

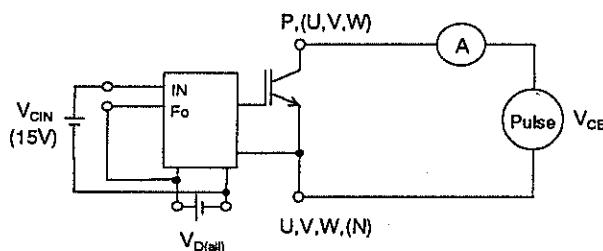


Fig.4 ICES Test

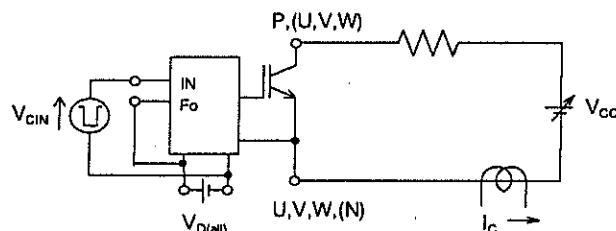


Fig.5 SC Test

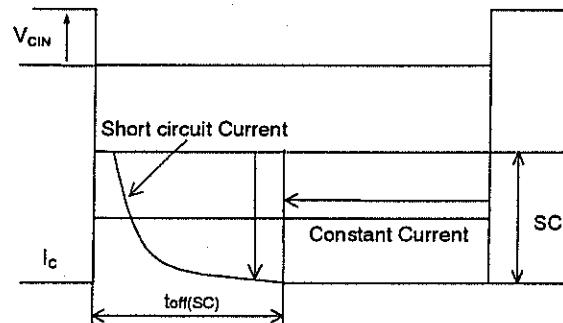


Fig.6 SC Test waveform

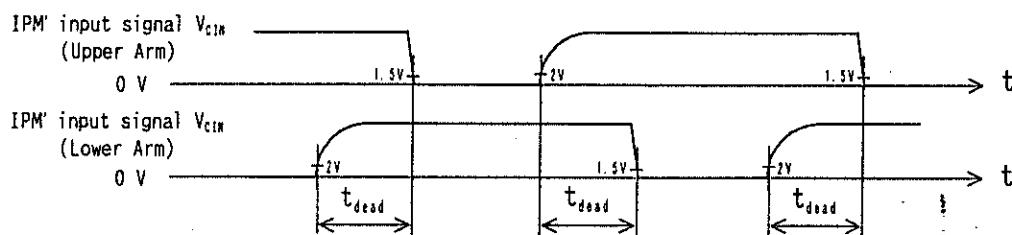
1.5V: Input on threshold voltage  $V_{th(on)}$  typical value, 2V: Input off threshold voltage  $V_{th(off)}$  typical value

Fig.7 Dead time measurement point example

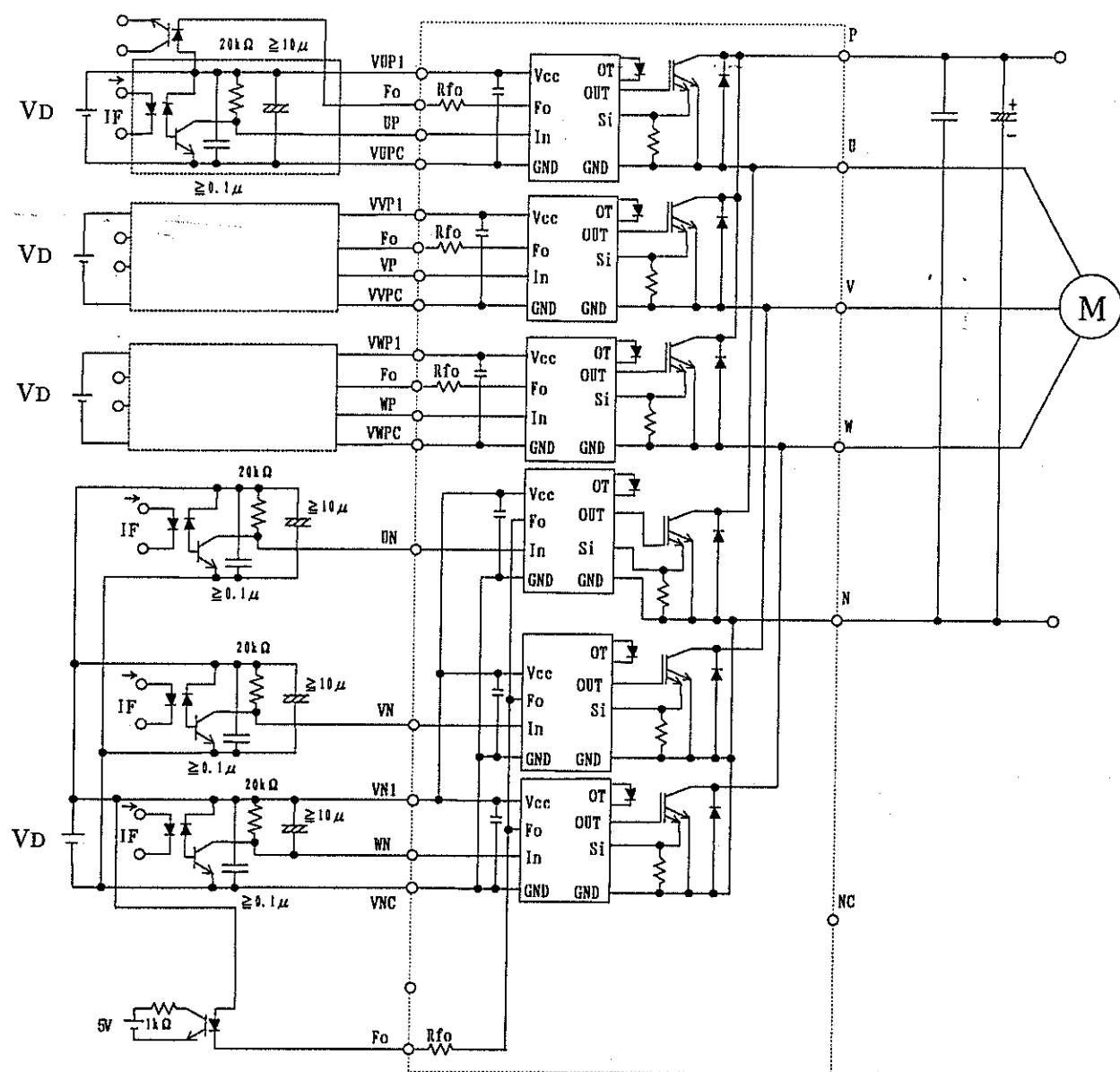


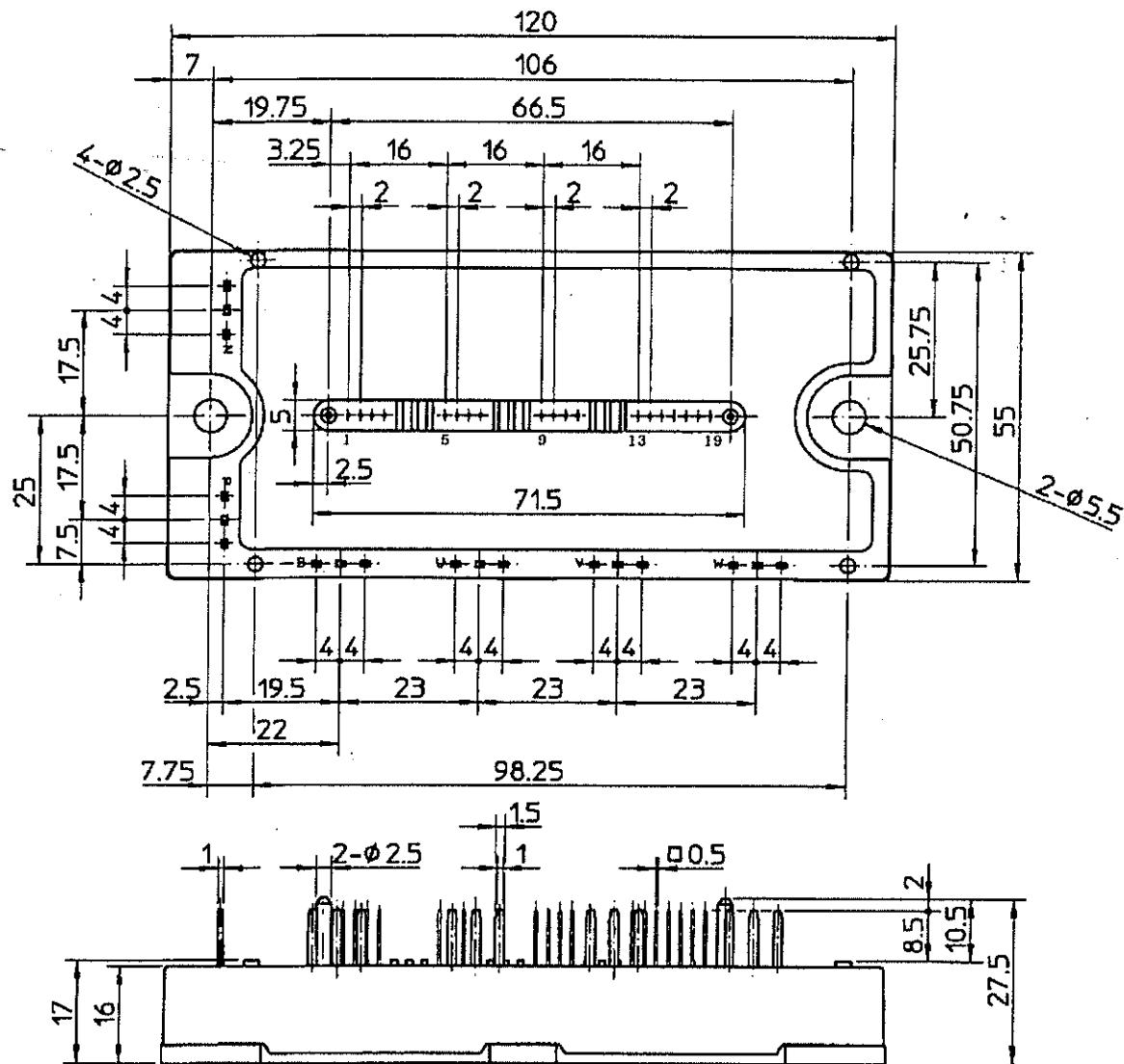
Fig. 8 Application Example Circuit

## Notes for stable and safe operation :

- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers :  $t_{PLH}, t_{PHL} \leq 0.8 \mu s$ , Use High CMR type.
- Slow switching opto-coupler :  $CTR > 100\%$
- Use 4 isolated control power supplies (  $V_D$  ). Also, care should be taken to minimize the instantaneous voltage change of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.
- Use line noise filter capacitor ( ex.  $4.7nF$  ) between each input AC line and ground to reject common mode noise from AC line and improve noise immunity of the system.

## Outline drawings

[Dimensions in mm]



## Terminal code

- |         |         |          |        |
|---------|---------|----------|--------|
| 1. VUPC | 6. VFO  | 11. WP   | 16. UN |
| 2. UFO  | 7. VP   | 12. VWP1 | 17. VN |
| 3. UP   | 8. VVP1 | 13. VNC  | 18. WN |
| 4. VUP1 | 9. VWPC | 14. VN1  | 19. Fo |
| 5. VVPC | 10. WFO | 15. NC   |        |

